



Development of a Rn removal system for future Xe-based neutrino detectors using resonant ionization

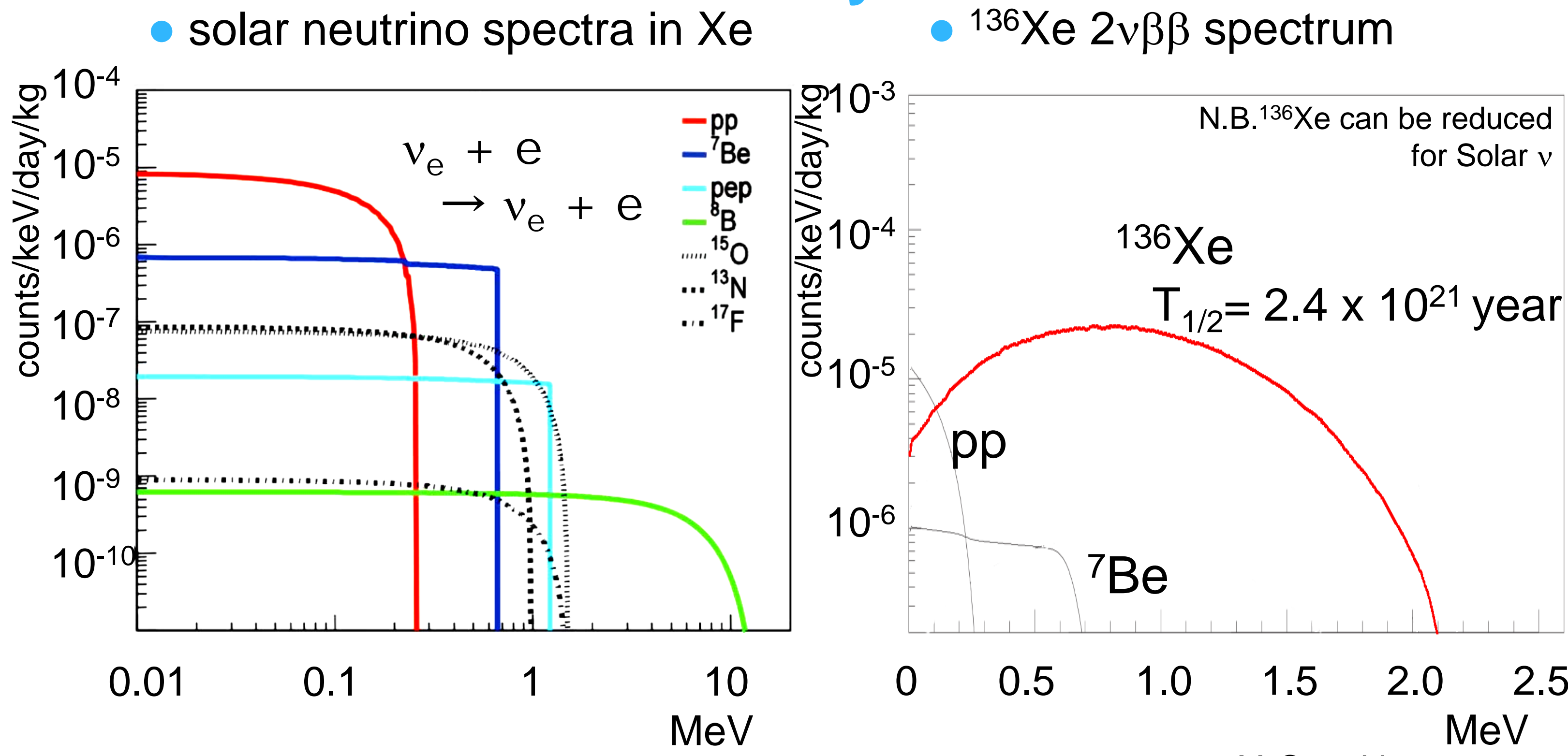


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Preface: Radon is one of the major background sources in low energy neutrino experiments. Accordingly it is essential to suppress radon events in future large-scale xenon detectors aiming for neutrino-less double beta decay and pp solar neutrino measurements. Although the removal of radon from air using adsorption on activated charcoal is well established, because its chemical properties are similar to those of radon this technique cannot be used with xenon; Xenon itself adsorbs to charcoal and thereby deteriorates its radon absorption efficacy. So we propose a new radon removal method.

1. Xe-based neutrino detector

-beyond dark matter search

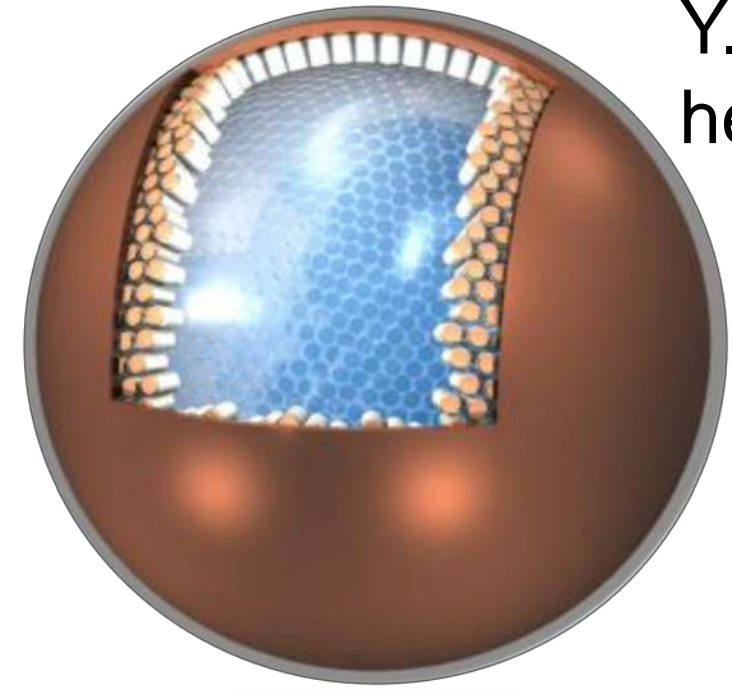


XMSS as an example

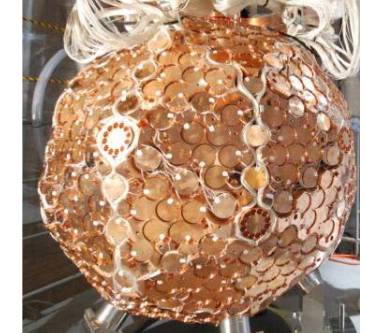
Future XMSS-II

pp 14 events/day
 ^7Be 7 events/day

24ton
10ton fiducial
 \varnothing 2.5m



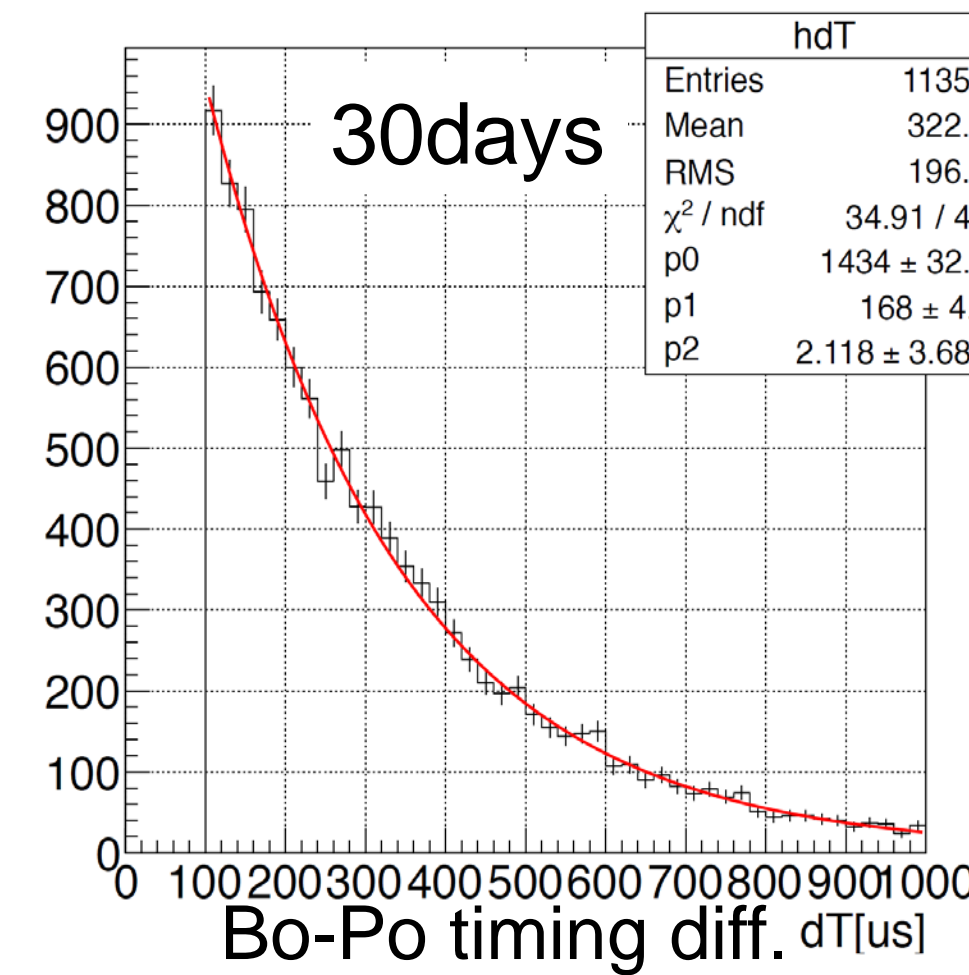
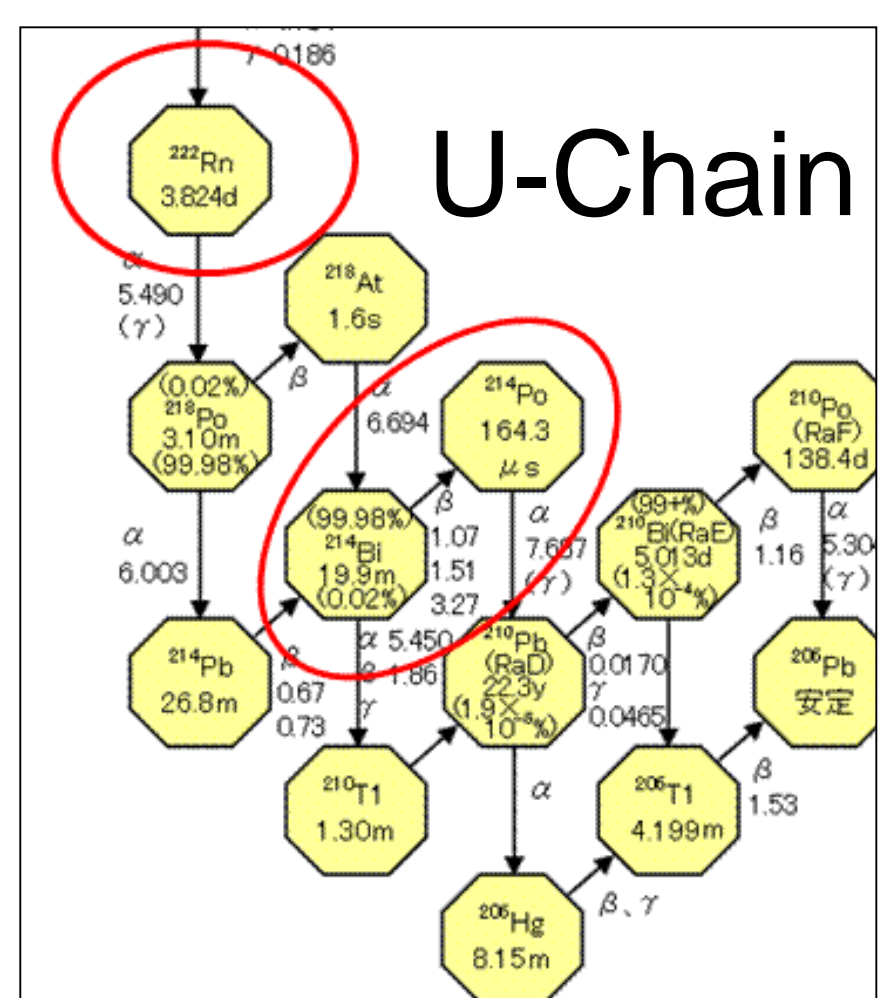
XMSS-I



1ton
100kg fiducial
 \varnothing 80cm

• Current ^{222}Rn level in XMSS-I

From the ^{214}Bi - ^{214}Po chain events (dT 164 μs) in 30 days commissioning data



8.2mBq/835kg
(emanated from the detector itself)

gives BG of 10^{-4} counts/keV/day/kg

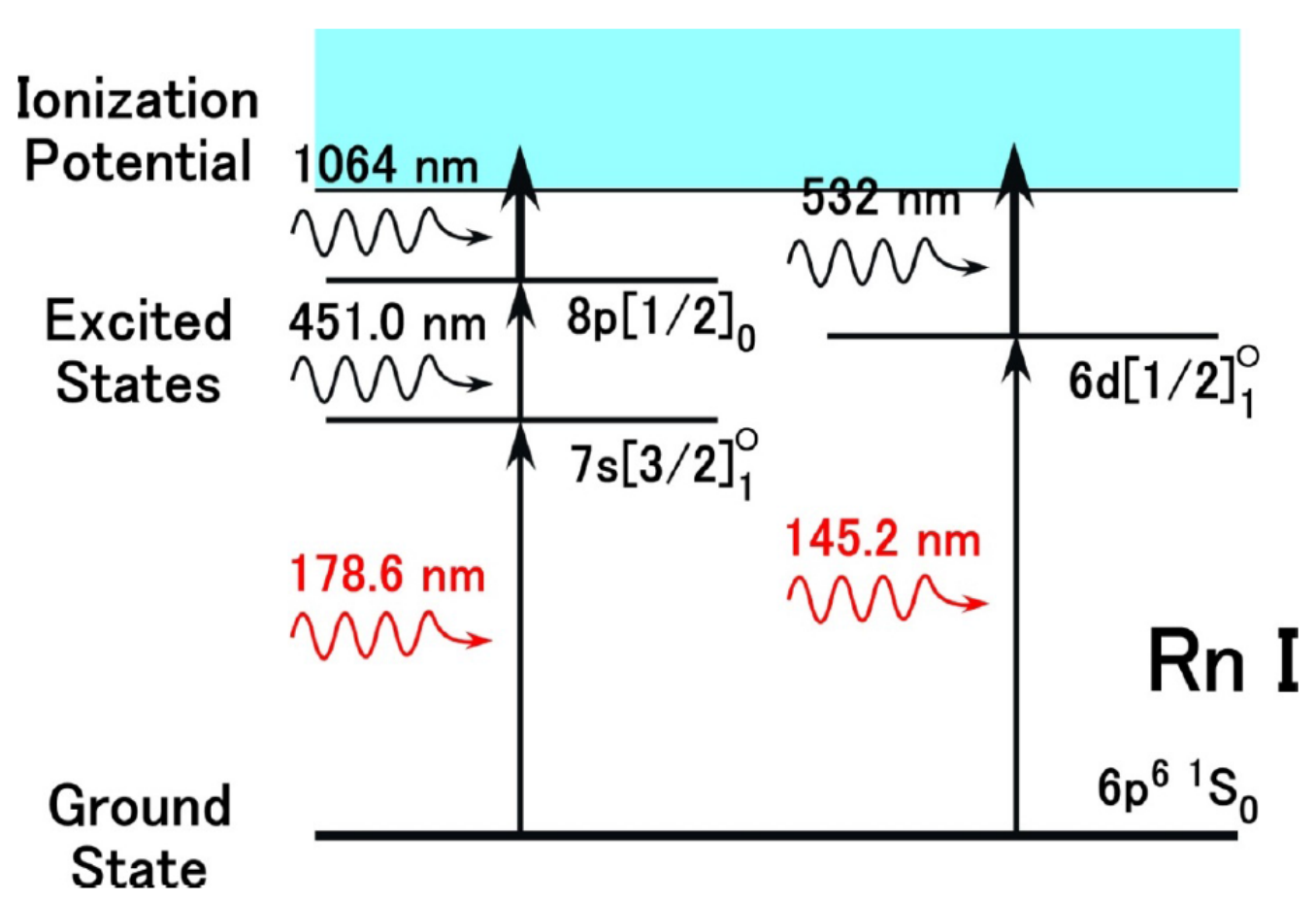
To observe pp ν (to achieve BG $\sim 10^{-6}$ counts/keV/day/kg), Rn must be reduced 1/100 and continuously removed.

2. Resonant ionization of Rn

Resonance-enhanced multi-photon ionization process

• A laser is used to promote radon atoms to an electronically excited state via resonant single- or multiple-photon absorption and these excited Rn atoms are then ionized by the introduction of another photon.

Rn Resonant ionization scheme

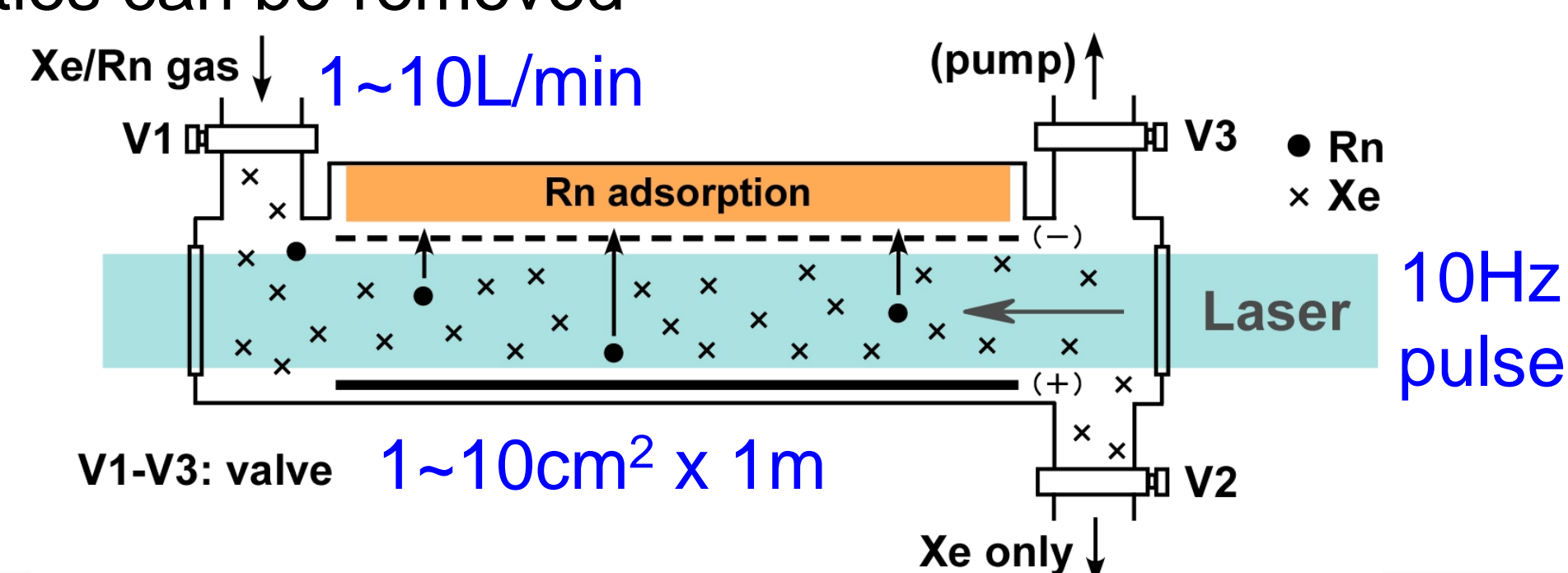


• Excitation cross section
Assuming laser's λ shape is Gaussian,
 $\sigma = g_2/g_1 \times \lambda^2 \times A_{21} / (8\sqrt{2} \times \pi^{3/2} \times \Delta\nu)$
 $\Delta\nu$: Laser linewidth [Hz]
 A_{21} : Einstein coefficient [s $^{-1}$]
In case of Rn $g_2/g_1 = 2J+1=3$
 $\lambda = 178.6\text{nm}$ or 145.2nm
 $A_{21} \sim 10^7 \text{ s}^{-1}$ (no ref., assuming Xe $5p^6 \ ^1S_0 \rightarrow 5d[1/2]_1$)
• Nano second pulse laser $\Delta\nu$ 1~10GHz
 $\sigma \sim 10^{-13} \text{ cm}^2$
 $145.2\text{nm} = 1.368 \times 10^{-12} \mu\text{J}$

$\rightarrow \sim 10\mu\text{J/pulse}$ laser is necessitated.

• Selectively ionized Rn impurities can be removed with an applied electric field.

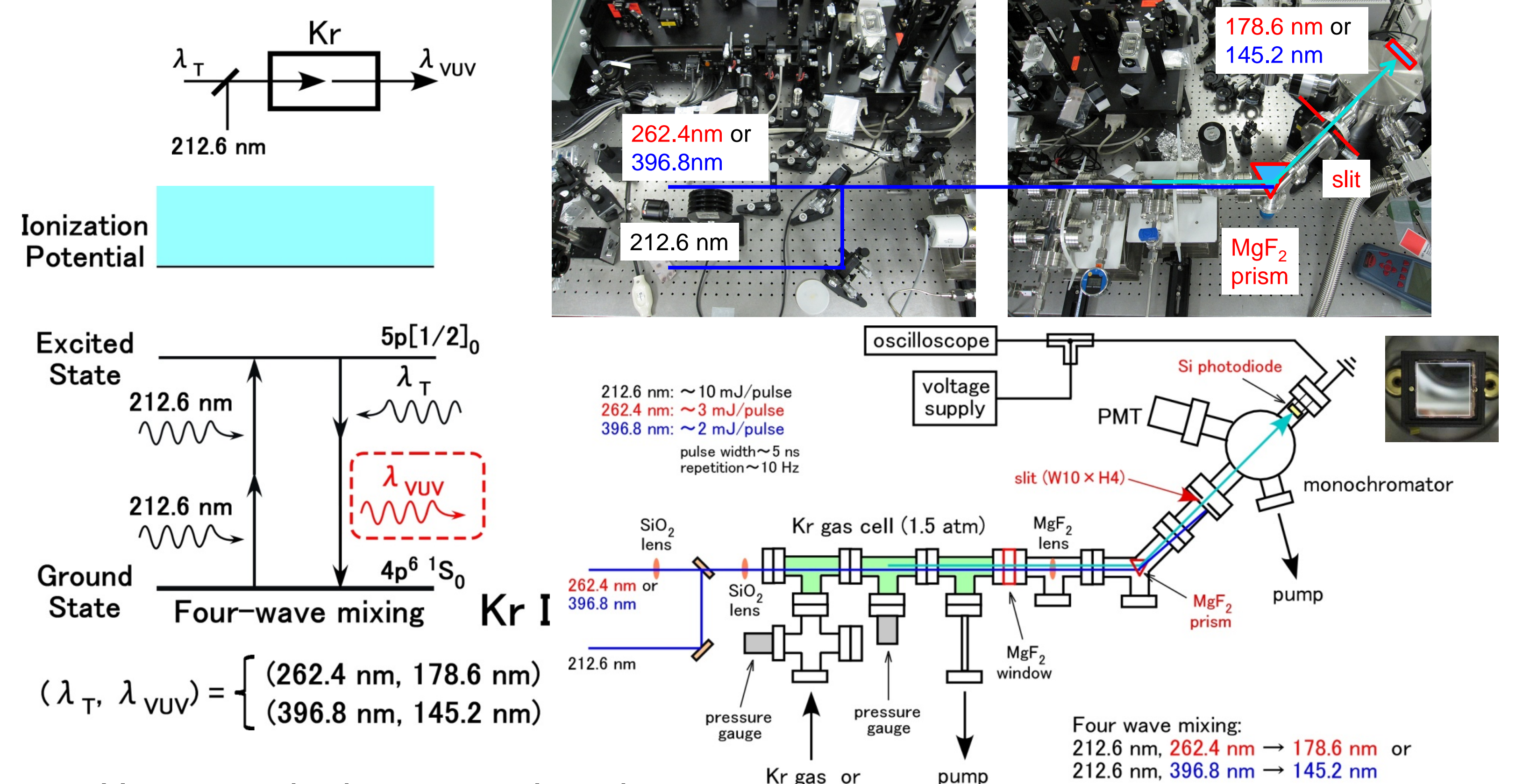
A possible system for 1/100 reduction



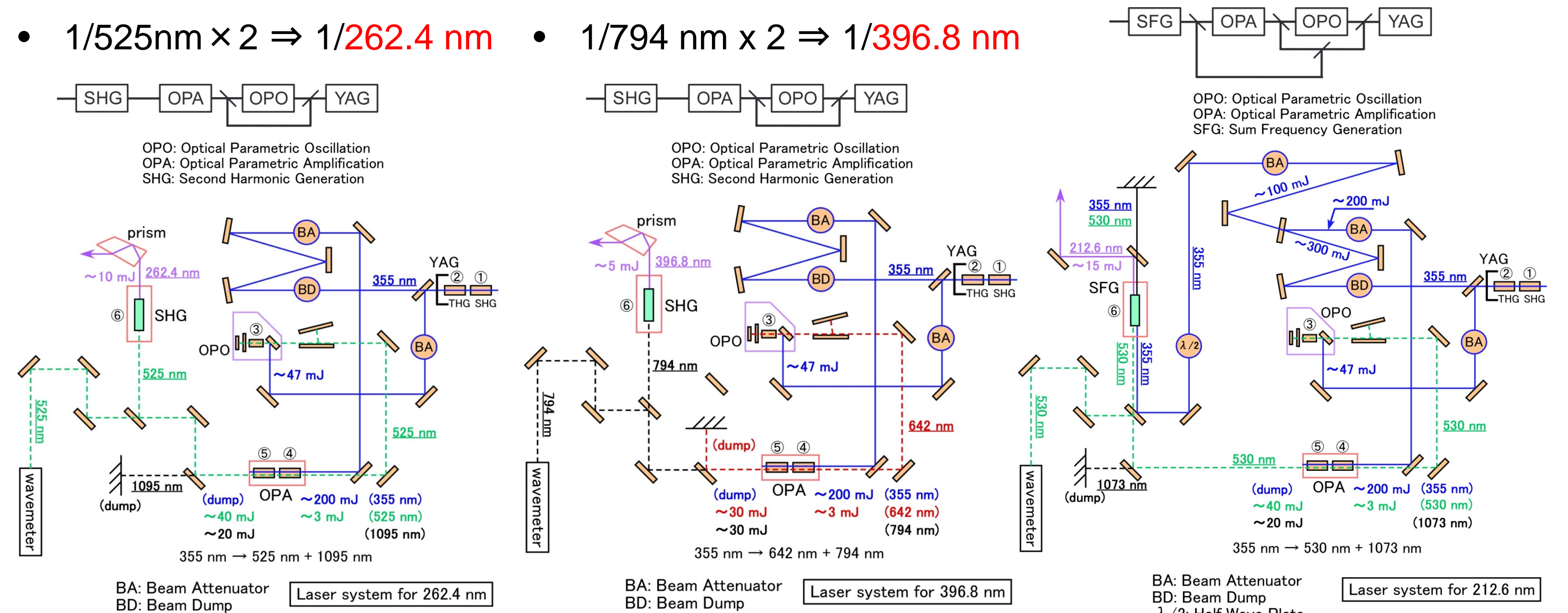
3. Development of Lasers

4 wave-mixing for making 178.6nm or 145.2nm

• Wavelength transformation in Kr gas cell

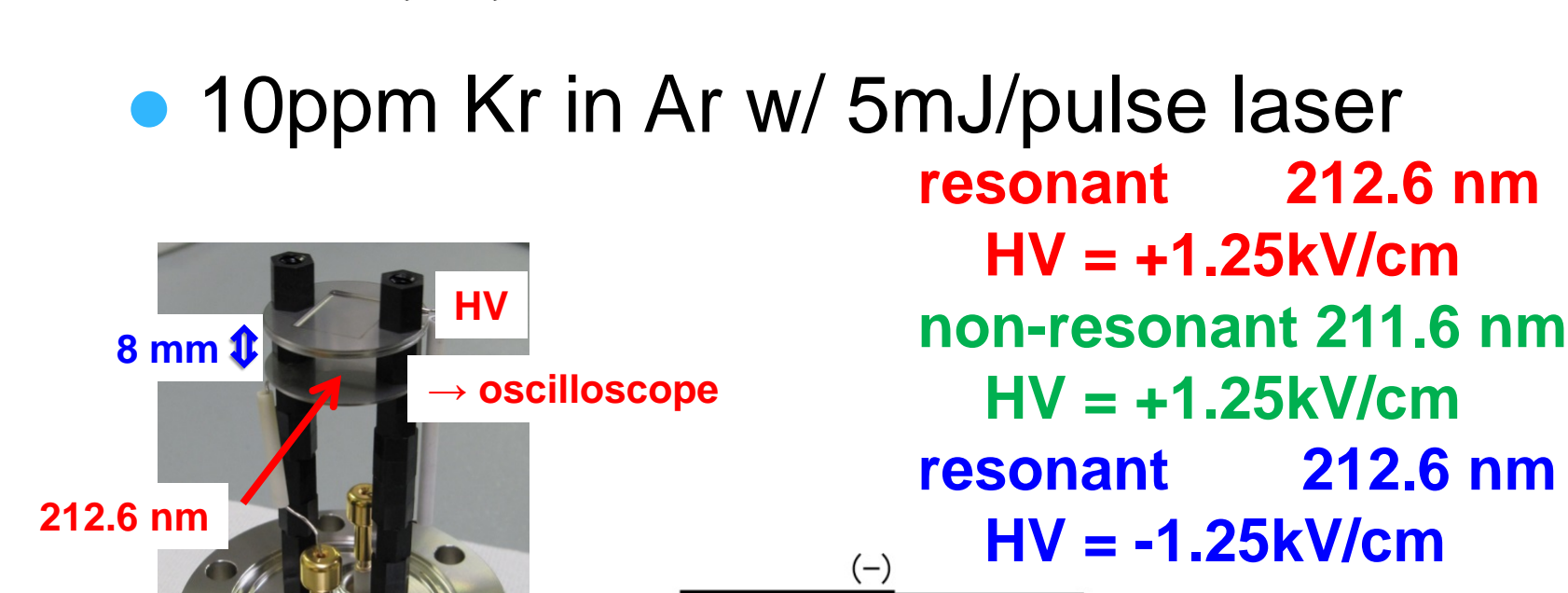
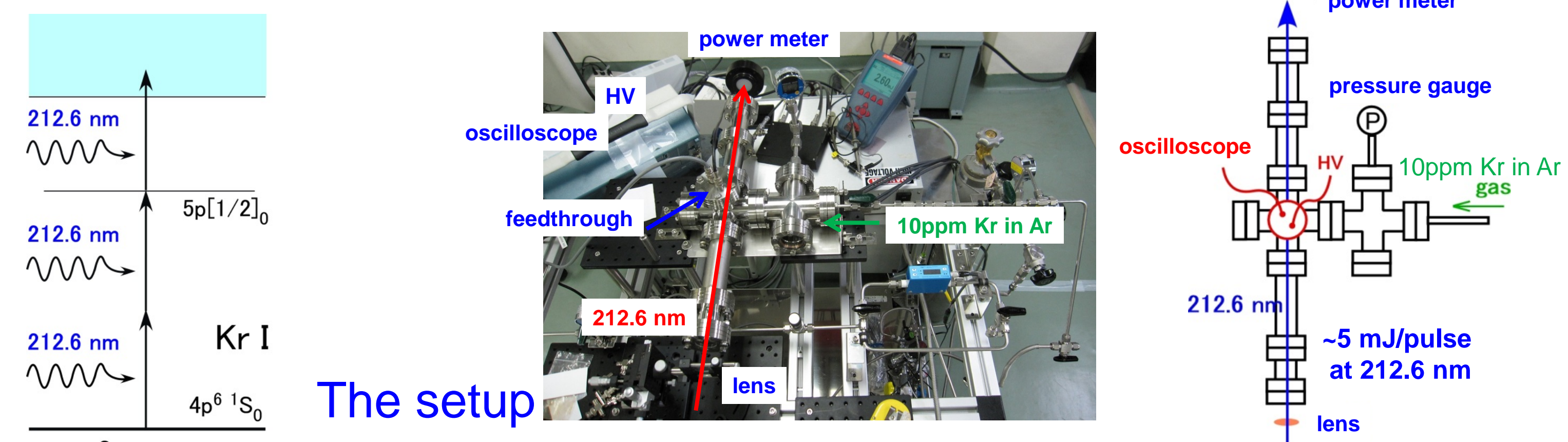


• How to make input wavelength



4. Test: Kr removal from Ar as a demonstration

• Kr can be resonantly ionized via 212.6nm $2\gamma+\gamma$



Conclusion: A system for removing Rn from Xe has been developed. In this study, the feasibility of this method was demonstrated by removing Kr from Ar. Since the necessary laser has already been developed, tests of Rn removal from Xe will begin soon.